


Search Notes 	Application/Control No. 10540658	Applicant(s)/Patent Under Reexamination MATHIES ET AL.
	Examiner Young J Kim	Art Unit 1637

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SEARCH NOTES		
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Patent Databases (USPT, USPGP, EPO, JPO, DERWENT, IBM-TDB)	2/8/2008	/YJK/
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